

Search Notes



Application/Control No.

10/779,758

Examiner

Mark H. Paschall

Applicant(s)/Patent under Reexamination

LEE ET AL.

Art Unit

3742

SEARCHED

| Class | Subclass | Date | Examiner |
|----------|-------------------|----------|----------|
| 219 | 739 722 723 | 12/10/05 | nm |
| | 724 | | |
| | 494 | | |
| | 412-414 | | |
| 292 | 53 44 | | |
| | 52 | | |
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| above to | | | |
| Class | | 5/25/06 | nm |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| 219 | 739 | 5-25-06 | nm |
| 219 | 506 | | |
| as above | | | |
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
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| Escb | | |
| 12/10/05 | 12/10/05 | nm |
| update Escb | 5/24/06 | nm |
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